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Include copy of this form with next communication to applicant.	EXAMINEI Include copy	R: Initia	l if citation considered, wheth	er or not citation is n to applicant.	s in conformance with MPEP 609; draw line three	ough citation	if not in conforma	nce and not	considered.

Form PTO-A820 also form PTO-1449 P09A/REV05

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